



Contribution ID: 99

Type: **Talk**

## **[211] UHV Growth and Characterization of Ga<sub>2</sub>O<sub>3</sub> on Cu<sub>2</sub>O(111)**

*Tuesday, 31 August 2021 16:30 (15 minutes)*

Cu<sub>2</sub>O, a natural p-type semiconductor with a direct bandgap of 2.17 eV, has a conventional conduction band position slightly above the water reduction potential and offers a low-cost photocathode for unassisted water splitting devices. Overlayers of n-type Ga<sub>2</sub>O<sub>3</sub> can be employed to reduce the interfacial recombination effects due to the adequate conduction band alignment with Cu<sub>2</sub>O, leading to an increase in photovoltage. In this work we investigate the electronic properties and the morphology of surfaces and interfaces of UHV-grown Ga<sub>2</sub>O<sub>3</sub> on Cu<sub>2</sub>O(111) with surface science methodology. In particular, we study the effect of post-annealing treatments and the influence of a reconstruction of the Cu<sub>2</sub>O(111) substrate prior to Ga<sub>2</sub>O<sub>3</sub> deposition.

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**Session Classification:** Surfaces, Interfaces and Thin Films

**Track Classification:** Surfaces, Interfaces and Thin Films